

Search Notes

Application/Control No.

10/736,509

Examiner

Y. J. Han

Applicant(s)/Patent under
Reexamination

YAMASHITA, TETSUJI

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
323	271		
	282		
	283		
	284		
	285		
	280		
	281		
	351		
	275		
	276		
	277		
	901	5/05	9A

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
323	285		
	284		
	275	5/05	9A